



INSTITUT  
Mines-Télécom

# Digital Systems

## Introduction

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## Exercise #1: what is the defect probability of a PCB

- ✓ Probability that a  $S$  cm<sup>2</sup> IC is defective after manufacturing with  $D\%$  defect probability per cm<sup>2</sup>:  $P_1 = 1 - (1 - D/100)^S$
- ✓ Probability that a  $S$  cm<sup>2</sup> IC is defective and passes a  $T\%$  coverage testing:  
 $P_2 = (1 - T/100) \times P_1$
- ✓ Probability that a  $N$  ICs board is not defective if each IC is defective with probability  $P_2$ :  $P_3 = (1 - P_2)^N$
- ✓ In our case ( $S = 1.5, D = 10\%, T = 97\%, N = 10$ ):  $P_3 \approx 0.957$ , that is a 4.3% probability of board defect...

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